

Description

The AO4612 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and

operation with gate voltages as low as 4.5V. This

device is suitable for use as a

Battery protection or in other Switching application.

General Features

V_{DS} = 60V I_D =8.5A

 $R_{DS(ON)} < 48m\Omega @ V_{GS}=10V$

V_{DS} = -60V I_D =-7.7A

 $R_{DS(ON)} < 85 \text{ m}\Omega @ V_{GS}=-10V$

Application

Wireless charging

Boost driver

Brushless motor

Package Marking and Ordering Information

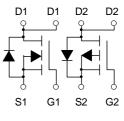
Product ID	Pack	Marking Qty(PC		
AO4612	SOP-8	4612XXX	3000	

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

	Barran	Rati	Units	
Symbol	Parameter	N-Channel	N-Channel P-Channel	
VDS	DS Drain-Source Voltage		-60	V
VGS	Gate-Source Voltage	±20	±20	V
I₀@T _A =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	8.5	-7.7	А
I₀@T _A =70°℃	Continuous Drain Current, V _{GS} @ 10V ¹	4.0	-3	А
IDM	Pulsed Drain Current ²	20	-14	А
EAS	Single Pulse Avalanche Energy ³	22	28.8	mJ
IAS	Avalanche Current	21	-24	А
P D@T A=25℃	Total Power Dissipation ⁴	2	2	W
TSTG	Storage Temperature Range	-55 to 150	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	-55 to 150	°C
R₀JA	Thermal Resistance Junction-Ambient ¹	85		°C /W
R₀JC	Thermal Resistance Junction-Case ¹	62.5		°C/W



SOP-8



N-Channel and P-Channel



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	60	65		V	
∆BVDSS/∆TJ	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.063		V/°C	
	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =5A		35	48	mΩ	
RDS(ON)		V _{GS} =4.5V , I _D =4A		41	65		
VGS(th)	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	1.2	1.75	2.5	V	
$\bigtriangleup V_{\text{GS(th)}}$	$V_{GS(th)}$ Temperature Coefficient	VGS-VDS, ID -2500A		-5.24		mV/°C	
IDSS	Drain-Source Leakage Current	V _{DS} =48V , V _{GS} =0V , T _J =25°C			1		
1055		V _{DS} =48V , V _{GS} =0V , T _J =55°C			5	uA	
IGSS	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA	
gfs	Forward Transconductance	V _{DS} =5V , I _D =4A		28		S	
Qg	Total Gate Charge (4.5V)			19		nC	
Qgs	Gate-Source Charge	V _{DS} =48V , V _{GS} =4.5V , I _D =4A		2.6			
Qgd	Gate-Drain Charge			4.1			
Td(on)	Turn-On Delay Time			3			
Tr	Rise Time Turn-Off Delay Time	V _{DD} =30V , V _{GS} =10V , R _G =3.3Ω, I _D =4A		34		ns	
Td(off)				23			
T _f	Fall Time			6.0			
Ciss	Input Capacitance			1027			
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		65		pF	
Crss	Reverse Transfer Capacitance			45			
IS	Continuous Source Current ^{1,5}	$V_G=V_D=0V$, Force Current			2.5	Α	
VSD	VSD Diode Forward Voltage ² V _{GS} =0V , I _S =1A , T _J =25°C				1.2	V	

N-Channel Electrical Characteristics (TJ =25 °C, unless otherwise noted)

Note :

1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.

 $2\,{\scriptstyle \sim}\,$ The data tested by pulsed , pulse width $\leq 300 us$, duty cycle $\leq 2\%$

3. The power dissipation is limited by 150°C junction temperature

4. The data is theoretically the same as I D and I DM, in real applications, should be limited by total power dissipation



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	ge V _{GS} =0V , I _D =-250uA		-65		V	
∆BVDSS/∆TJ	$DSS/\Delta TJ$ BV _{DSS} Temperature Coefficient Reference to 25°C , I _D =-1mA			-0.03		V/°C	
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =-10V , I _D =-3A		72	85	mΩ	
RD3(ON)		V _{GS} =-4.5V , I _D =-2A		100	105	11122	
VGS(th)	Gate Threshold Voltage	V_{GS} = V_{DS} , I_D =-250uA	-1.2	1.75	-2.5	V	
	Drain-Source Leakage Current	V _{DS} =-48V , V _{GS} =0V , T _J =25°C			1	uA	
IDSS		V _{DS} =-48V , V _{GS} =0V , T _J =55°C			5		
IGSS	Gate-Source Leakage Current	V_{GS} =±20V , V_{DS} =0V			±100	nA	
gfs	fs Forward Transconductance V _{DS} =-5V , I _D =-3A			8.5		S	
Qg	Total Gate Charge (-4.5V)			12.1			
Qgs	Gate-Source Charge	V _{DS} =-48V , V _{GS} =-4.5V , I _D =-3A		2.2		nC	
Qgd	Gate-Drain Charge			6.3			
Td(on)	Turn-On Delay Time			9.2			
Tr	Rise Time	V _{DD} =-15V , V _{GS} =-10V ,		20.1			
Td(off)	Turn-Off Delay Time	R _G =3.3□, I _D =-1A		46.7		ns	
T _f	Fall Time			9.4			
Ciss	Input Capacitance			1137			
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		76		pF	
Crss	Reverse Transfer Capacitance			50			
IS	Continuous Source Current ^{1,5}	$V_G=V_D=0V$, Force Current			-2.5	Α	
VSD	VSD Diode Forward Voltage ² V _{GS} =0V , I _S =-1A , T _J =25°C				-1.2	V	

P-Channel Electrical Characteristics (TJ =25 °C, unless otherwise noted)

Note :

1、The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.

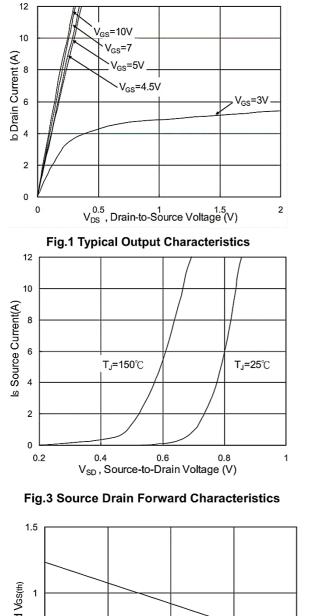
2、 The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%

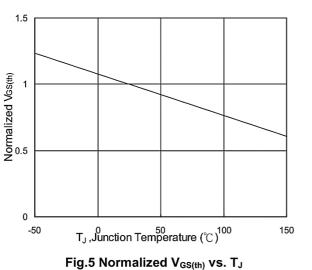
3. The power dissipation is limited by 150°C junction temperature

4、The data is theoretically the same as I D and I DM , in real applications , should be limited by total power dissipation.



N-Channel Typical Characteristics





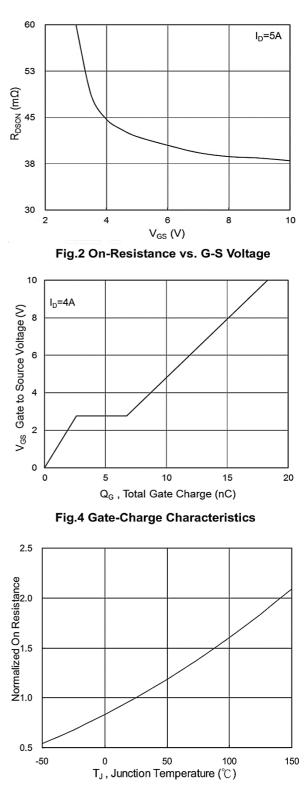
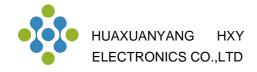


Fig.6 Normalized R_{DSON} vs. T_J



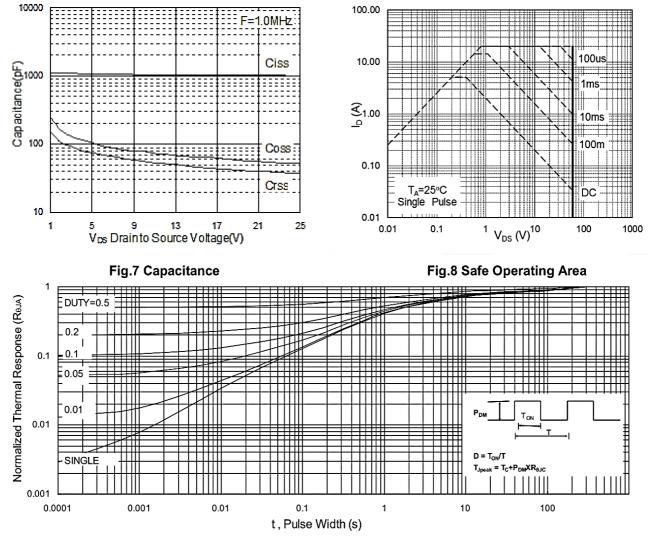


Fig.9 Normalized Maximum Transient Thermal Impedance

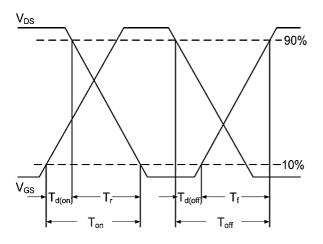
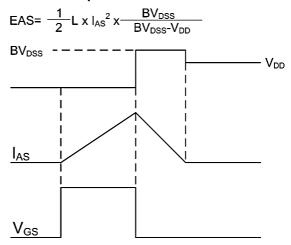
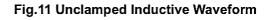


Fig.10 Switching Time Waveform







P-Channel Typical Characteristics

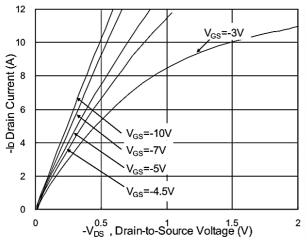


Fig.1 Typical Output Characteristics

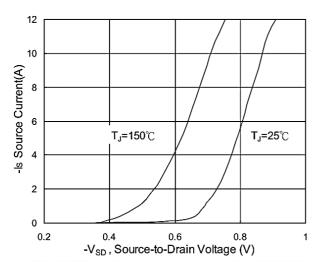
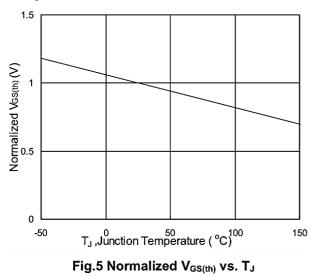


Fig.3 Source Drain Forward Characteristics



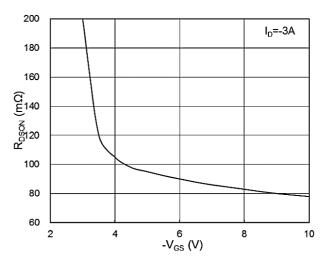


Fig.2 On-Resistance vs. G-S Voltage

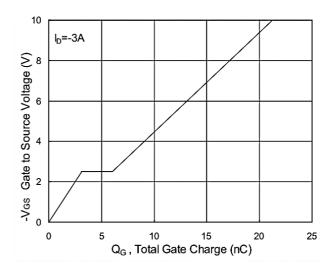


Fig.4 Gate-Charge Characteristics

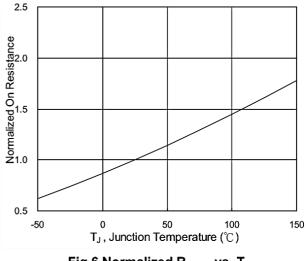


Fig.6 Normalized R_{DSON} vs. T_J



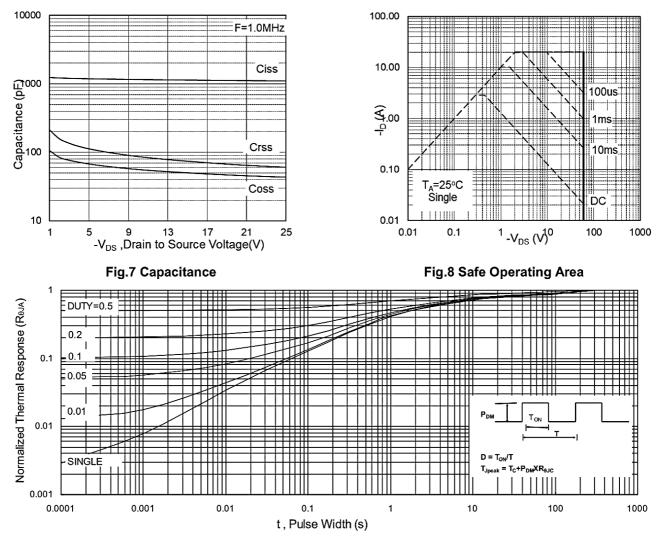


Fig.9 Normalized Maximum Transient Thermal Impedance

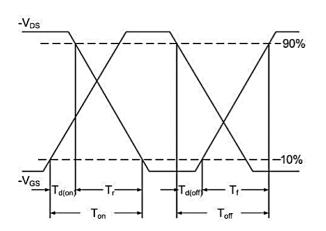
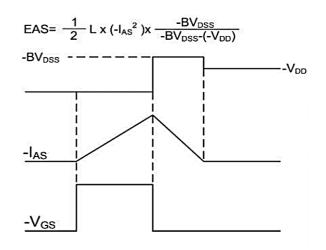
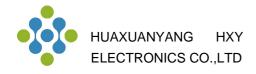


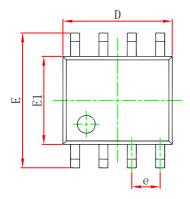
Fig.10 Switching Time Waveform

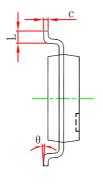


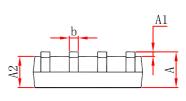




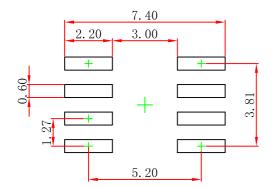
SOP-8 Package Outline Dimensions







Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
с	0.170	0.250	0.007	0.010	
D	4.800	5.000	0.189	0.197	
e	1.270 (BSC)		0.050 (BSC)		
E	5.800	6.200	0.228	0.244	
E1	3.800	4.000	0.150	0.157	
L	0.400	1.270	0.016	0.050	
θ	0 °	8°	0 °	8°	



Note: 1.Controlling dimension: in millimeters.

2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.



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